IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	
Filing Date	April 21, 2001
Inventor	Luan C. Tran
Assignee	Micron Technology, Inc.
Group Art Unit	
Customer No	
Confirmation No	
Examiner	Laura Schillinger
Attorney's Docket No	Ml22-1637
Customer No	021567
Title:	Semiconductor Processing Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT References -See Attached Form PTO-1449

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated:	1/21/05	By: 1201
		James D. Shaurette Reg. No. 39,833

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Sheet 1 of 2

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Form PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. SERIAL NO. 09/834,660				<u>.</u>			
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Luan C. Tran						
,				FILING DATE April 21, 2001			GROUP 2813			
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*Examiner Initial		Document Number	Date	Name		Class	Subclass		Filing Date If Appropriate	
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applicant.

Sheet 2 of 2 ATTY. DOCKET NO. SERIAL NO. U.S. DEPARTMENT OF COMMERCE Form PTO-1449 09/834,660 PATENT AND TRADEMARK OFFICE MI22-1837 APPLICANT LIST OF ART CITED BY APPLICANT Luan C. Tren (Use several sheets if necessary) GROUP FILING DATE 2813 April 21, 2001 **U.S. PATENT DOCUMENTS** Filing Date Subclass Name . Class Date Document *Examiner If Appropriate Initial Number 1/2003 AA 2003/0001181 Loung ot al. 12/2002 Tran AB 2002/0195670 1/2005 Shou et al. 2005/0012173 AC AD 2005/0029599 2/2005 Tran 2005/0285201 12/05 Tren ΑE 12/2005 AF 2005/0285163 Tran 12/2005 Tran 2005/0287733 AG 1/2006 Tran AΗ 2006/0008977 4/2008 Sheu et al. 2006/0079068 ΑI Miura et al. 10/2004 2004/0214355 A1 2001/0020724 9/2001 Berry et al. AK FOREIGN PATENT DOCUMENTS Subclass Translation Class Date Country Document Number Yes Νọ AL AM OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AN **EXAMINER** DATE CONSIDERED *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to